



Certificate of Analysis

IARM 343A

Alloy 7055 / UNS A97055

Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

B	0.0007 ± 0.0003	Ca	0.0024 ± 0.0003	Cr	0.0009 ± 0.0002	Cu	2.29 ± 0.01
Fe	0.084 ± 0.004	Ga	0.012 ± 0.001	Mg	2.04 ± 0.01	Mn	0.002 ± 0.001
Ni	0.005 ± 0.002	P	0.0010 ± 0.0002	Pb	0.0012 ± 0.0003	Si	0.050 ± 0.002
Ti	0.0175 ± 0.0006	V	0.0058 ± 0.0005	Zn	8.15 ± 0.08	Zr	0.152 ± 0.004

Indicative Values listed in ppm

Ag (<30)	Be (<40)	Bi (<90)	Cd (2)	Co (8)	Na (5)	Sb (<40)
Sn (<50)	Sr (3)					

Description and Intended Use

This CRM may come in the form of a solid disc or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Interpretation of Data

1. Certified values listed reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community, and are reported as wt% unless otherwise noted.
2. This material was tested using both the solid disks and chips prepared from individual sections of bar. The certified values are considered representative of the overall average composition of the material.
3. Any data reported and enclosed by a parentheses () is a "best estimate" and is not certified. This data could not be quantified sufficiently for certification. It was, however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
4. "Provisional Certificate of Analysis" reports values that support a fully certified reference material; it also indicates that values may be in a continued process of statistical evaluation and are subject to change.
5. Chips are not certified for Oxygen analysis.



The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material.

	Ag	B	Be	Bi	Ca	Cd	Co	Cr	Cu	Fe	Ga	Mg	Mn	Na	Ni	P
1	0.0005	0.0003	0.0001	0.0012	0.0021	0.0001	0.0007	0.0004	2.24	0.0722	0.01023	2.003	0.0001	0.0001	0.0019	0.0006
2	0.0006	0.0005	0.0001	0.0065	0.0021	0.0002	0.0007	0.0005	2.27	0.078	0.011	2.008	0.0006	0.0001	0.0031	0.0009
3	0.001	0.0008	0.0004	0.0075	0.0023	0.0002	0.001	0.0005	2.27	0.0804	0.0117	2.01	0.0009	0.0001	0.0033	0.001
4	0.0015	0.0009	0.0035	0.009	0.0024	0.0003	<0.0001	0.001	2.274	0.081	0.0121	2.024	0.001	0.0006	0.0036	0.001
5	0.0028	0.0009	<0.0001	<0.00002	0.0024	<0.0001	<0.005	0.001	2.2753	0.082	0.0129	2.032	0.0011	0.0017	0.004	0.0011
6		0.001	<0.001	<0.001	0.0028	<0.0001	<0.0100	0.001	2.28	0.082	0.0135	2.0431	0.0015	<0.0001	0.004	0.0011
7			<0.001	<0.01	0.003	<0.005		0.001	2.282	0.0837	0.0136	2.05	0.0016	<0.005	0.0043	
8			<0.005					0.001	2.284	0.086	0.0138	2.05	0.003		0.005	
9								0.0013	2.29	0.088		2.0519	0.003		0.005	
10									2.294	0.0882		2.055	0.006		0.0059	
11									2.3015	0.089		2.056			0.0095	
12									2.3027	0.089		2.0626			0.0098	
13									2.31	0.0987		2.076				
14									2.3275			2.0776				
15																
Mean	0.001	0.0007	0.001	0.006	0.0024	0.0002	0.0008	0.0009	2.29	0.084	0.012	2.04	0.002	0.0005	0.005	0.001
STDV.	0.0009	0.0003	0.002	0.003	0.0003	0.00008	0.0002	0.0003	0.02	0.006	0.001	0.02	0.002	0.0007	0.002	0.0002
Certified	<0.003	0.0007	<0.004	<0.009	0.0024	(0.0002)	(0.0008)	0.0009	2.29	0.084	0.012	2.04	0.002	(0.0005)	0.005	0.0010
95% C.I.	0.0003	0.0003			0.0003			0.0002	0.01	0.004	0.001	0.01	0.001		0.002	0.0002
Methods	O,IM,I	O,IM,I	O,IM,I	O,IM,I,G	O,I,G	O,IM,I	O,IM,I	O,IM,I,G	O,I,G	O,IM,I,G	O,IM,I	O,I,G	O,IM,I,G	O,IM,I	O,IM,I,G	O,IM,I

	Pb	Sb	Si	Sn	Sr	Ti	V	Zn	Zr							
1	0.0004	0.0035	0.043	0.0001	0.0002	0.015	0.0041	7.8842	0.1447							
2	0.0009	0.0037	0.0433	0.0003	0.0003	0.0168	0.005	8.0027	0.145							
3	0.001	<0.0001	0.0481	0.001	0.0004	0.017	0.0054	8.01	0.145							
4	0.001	<0.0001	0.0482	0.0018	<0.0001	0.017	0.0054	8.058	0.1464							
5	0.0011	<0.0020	0.05	0.002	<0.0001	0.017	0.0056	8.068	0.147							
6	0.0012	<0.005	0.05	0.0023	<0.005	0.0171	0.0056	8.114	0.148							
7	0.0013		0.0509	0.0048		0.0173	0.006	8.144	0.149							
8	0.0014		0.051	0.005		0.0174	0.0062	8.1916	0.15							
9	0.002		0.052			0.0178	0.0064	8.1971	0.153							
10			0.052			0.018	0.0065	8.2236	0.1532							
11			0.0526			0.018	0.0066	8.27	0.1615							
12			0.054			0.0181	0.0069	8.28	0.162							
13			0.0542			0.0183		8.33	0.1621							
14			0.0573			0.0198		8.34	0.163							
15																
Mean	0.0012	0.004	0.05	0.002	0.0003	0.0175	0.0058	8.15	0.152							
STDV.	0.0005	0.0001	0.004	0.002	0.0001	0.001	0.0008	0.1	0.007							
Certified	0.0012	<0.004	0.050	<0.005	(0.0003)	0.0175	0.0058	8.15	0.152							
95% C.I.	0.0003		0.002	0.002		0.0006	0.0005	0.08	0.004							
Methods	O,IM,I,G	O,IM,I	O,IM,I,G	O,IM,I,G	O,IM,I	O,IM,I,G	O,IM,I,G	O,I,G	O,IM,I,G							

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES



Participating Laboratories

LECO Corporation
Dirats Laboratories
NSL Analytical Services
SGS MSi
Anderson Laboratories, Inc.
IMR Test Labs

St. Joseph, MI
Westfield, MA
Cleveland, OH
Melrose Park, IL
Greendale, WI
Lansing, NY

Wagstaff, Inc.
Laboratory Testing, Inc.
Element - Newtown
Special Metals IncoTest
Exova - Gary
Laboratorio Prove Materiali S. Marco srl

Spokane Valley, WA
Hatfield, PA
Newtown, PA
Hereford, UK
Gary, IN
Schio, Italy

Traceability

Members of the "Inter-Laboratory Analysis Program" (ILAP) validate test methods and instrument performance utilizing SRMs, CRMs, and RMs produced by recognized Certifying Bodies. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALCAN 524-01	ALCAN ALC-7075AB	ALCOA SS-535Y	ALCOA SS-7075GJ	BCS 263/1	IARM 111A	NIST 3106	NIST 3119A	NIST 3152A
ALCAN 7075AF	ALCAN ALC-7075AD	ALCOA SS-6061	ALCOA SS-713F	BCS 300	IH 7050-AY	NIST 3107	NIST 3128	NIST 3153A
ALCAN 722-01	ALCAN ALU 234-01	ALCOA SS-7050AW	ALCOA SS-713H	BCS 300/1	MBH 59XG77J2E	NIST 3108	NIST 3129A	NIST 3161A
ALCAN ALC-1188AB	ALCAN VAW 3433	ALCOA SS-7075DW	ALCOA SS-852 C20	BCS 300/14	NIST 1259	NIST 3109A	NIST 3132	NIST 859
ALCAN ALC-2618AC	ALCOA SA-1553 11	ALCOA SS-7075FZ	BCS 181/2	IARM 104A	NIST 3102A	NIST 3112A	NIST 3139A	REYNOLDS N7050A
ALCAN ALC-6463AC	ALCOA SS-2219T	ALCOA SS-7075GC	BCS 216/3	IARM 109A	NIST 3105A	NIST 3113	NIST 3151	

Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity is also determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where $H=U_{hom}$, S = Standard deviation, t = t-value at 95% CI, and n = number of observations.

$$1. N_{min} = \max(10, \sqrt[3]{N_{prod}})$$

$$2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30–1992 list the following:

Certifying Body: Any technically competent body (organization or firm, public or private) that issues a reference material certificate with the information detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards or Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance, with one or more property values that are sufficiently homogeneous and well established, to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): Reference material, accompanied by a certificate, with one or more property values certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

Inter-Laboratory Analysis Program (ILAP): ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", but also outlines a well thought out and logical plan for conducting an inter laboratory program involving multiple analytical techniques. Therefore, the guidelines established in ASTM E691-87 were applied to all aspects of this inter laboratory program, including the protocols for planning, handling, analysis and treatment of resulting data.

Methods of Analysis: The "Inter Laboratory Analysis Program" analyzes a wide variety of materials, and as a result, no single analytical method would provide optimum analytical results. Therefore, a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, X-Ray spectrometric, and other accepted methods were used to produce analytical data. Carbon, Sulfur, Nitrogen, and Oxygen results were supplied from combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is on the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. **Chips are not to be used for Oxygen analysis.**

Selection of Materials: A "batch" or "series" is defined as a continuous length of bar produced from a single heat. The majority of IARM materials are in wrought condition; other methods of manufacture are utilized if necessary. ILAP samples are removed from equal sections from the total length of the bar. A portion of each section is converted to chips and a thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis.



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